Introducing the UCIe™ 2.0 Specification: Supporting 3D Packaging and Manageability System Architecture

Dr. Debendra Das Sharma Intel Senior Fellow and co-GM Memory and I/O Technologies, Intel Corporation Chair of UCIe Consortium



Meet the Presenter



Dr. Debendra Das Sharma
Intel Senior Fellow and co-GM Memory
and I/O Technologies, Intel Corporation
UCIe Consortium Chairman

Agenda

- Introducing UCIe
- UCIe 1.0/1.1: Overview
- UCIe 2.0: Vertical Chiplets with UCIe-3D
- UCIe 2.0: Addressing SIP challenges through common infrastructure
- Future Directions and Conclusions



Universal Chiplet Interconnect Express™ (UCIe):

An Open Standard for Chiplets

Guiding principles of UCIe

- 1. Open Ecosystem with Plug-and-play
- 2. Backward compatible evolution when appropriate to ensure investment protection
- 3. Best power, performance, and cost metrics across the industry applicable across the entire compute continuum
- 4. Continuously innovate to meet the needs of evolving compute landscape

(Leveraging decades of experience driving successful industry standards at the board level: PCIe, CXL, USB, etc.)



Board Members

Leaders in semiconductors, packaging, IP suppliers, foundries, and cloud service providers are joining together to drive

The open chiplet ecosystem.

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UCIe Consortium is Open for Membership

- UCIe Consortium welcomes interested companies and institutions to join the organization at the Contributor and Adopter level.
- **UCIe** was founded in March 2022, incorporated in June 2022. Two levels of memberships: Contributor and Adopter

Contributor Membership

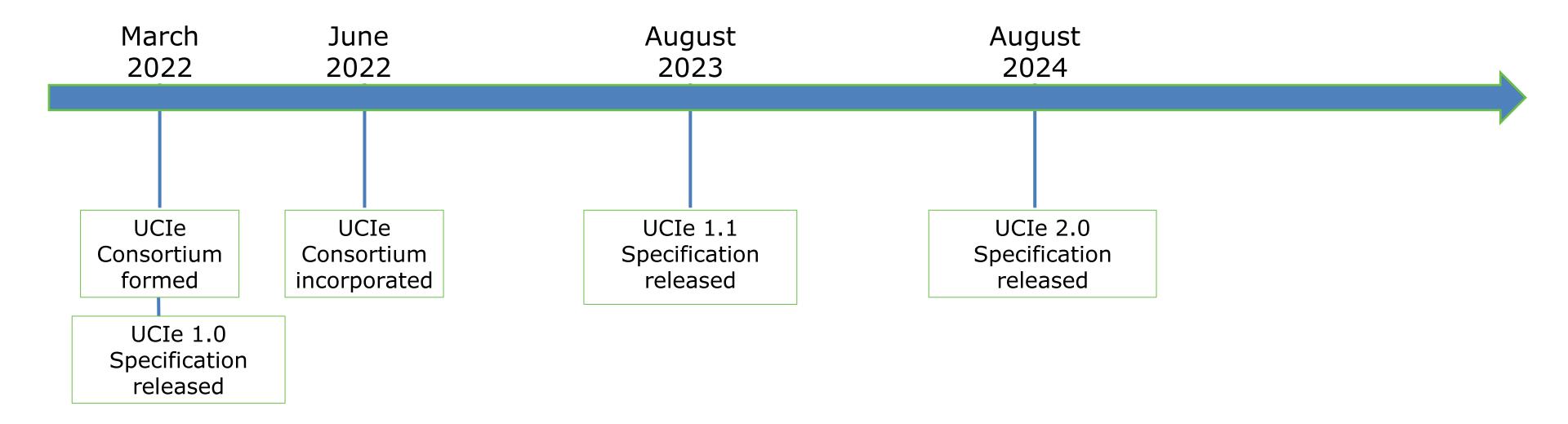
- Access the Final Specifications (ex: 1.0, 1.1, 2.0, etc.)
- Implement with the IP protections as outlined in the Agreements
- Right to attend Corporation trade shows or other industry events as determined by the Board
- Participate in the technical working groups
- Influence the direction of the technology
- Access the intermediate (dot level) specifications
- Election to get to the Promoter Class/ Board every year when the term of half the board completes

Adopter Membership

- Access the Final Specifications (ex: 1.0, 1.1, 2.0, etc.), but not intermediate level specifications
- Implement with the IP protections as outlined in the Agreements
- Right to attend Corporation trade shows or other industry events as determined by the Board

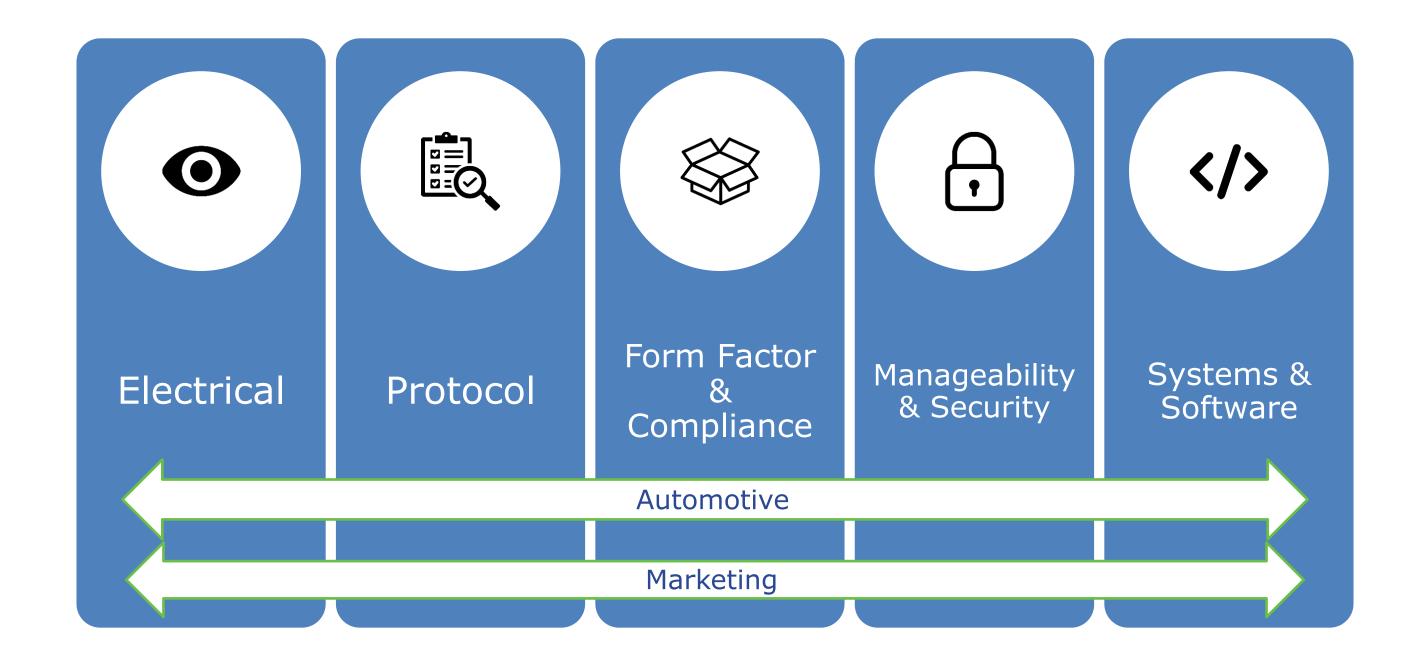


Member Driven Evolution



UCIe Consortium Working Groups

Working Groups are identifying and addressing the demands of a complete, full-stack solution for strengthening the open standards-based ecosystem.



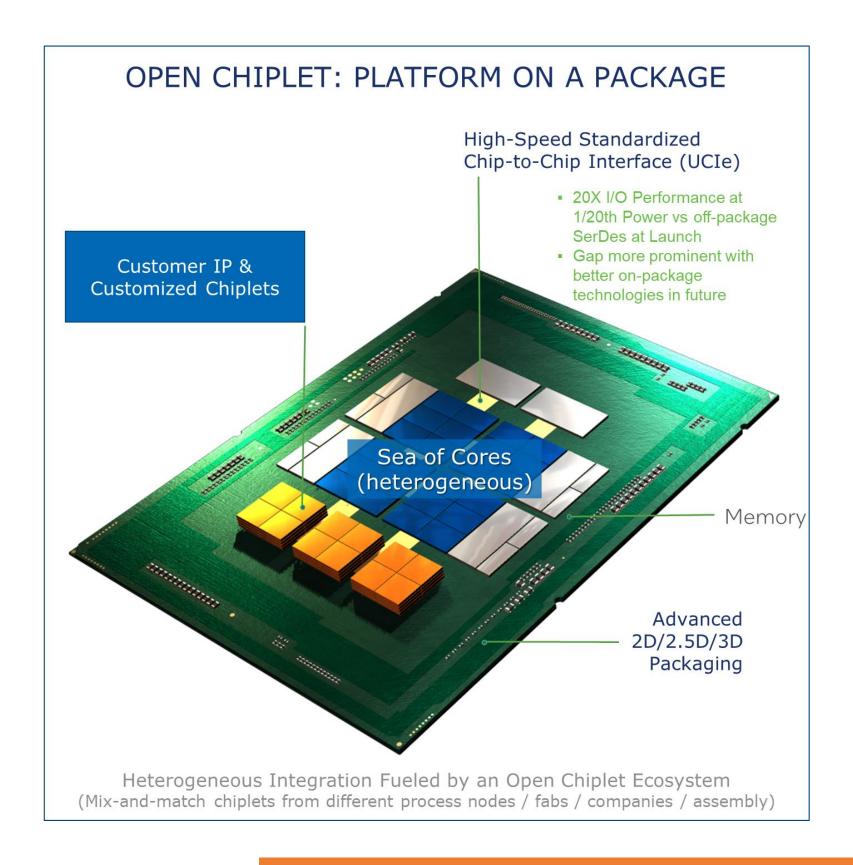


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- Introducing UCIe
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- UCIe 2.0: Addressing SIP challenges through common infrastructure
- UCIe Key Metrics
- Future Directions and Conclusions



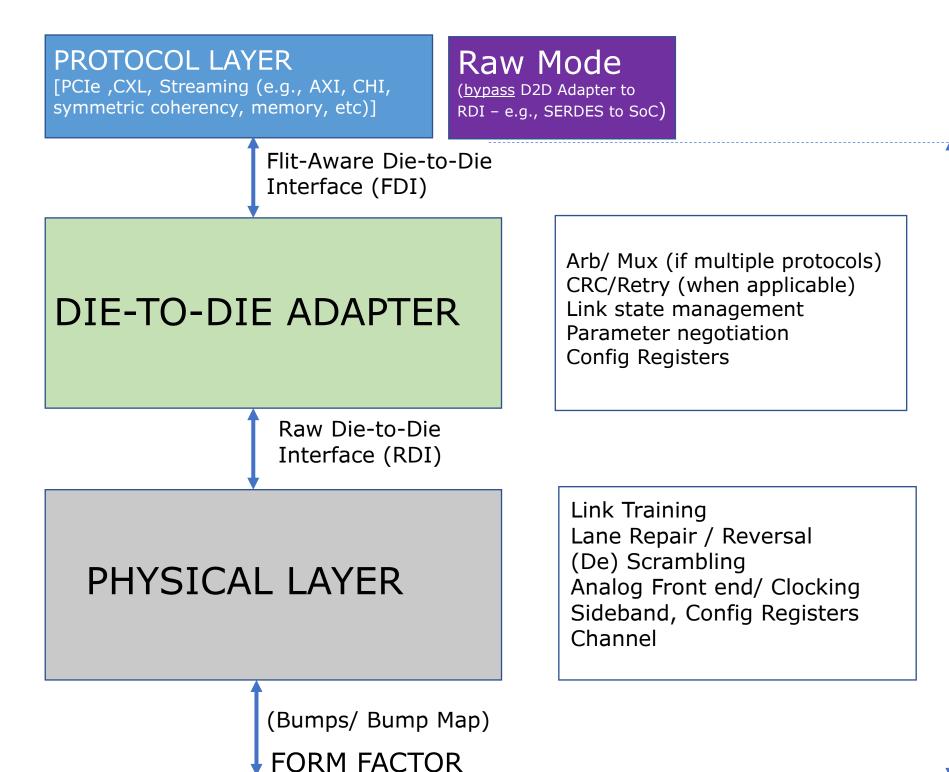
Motivation for UCIe



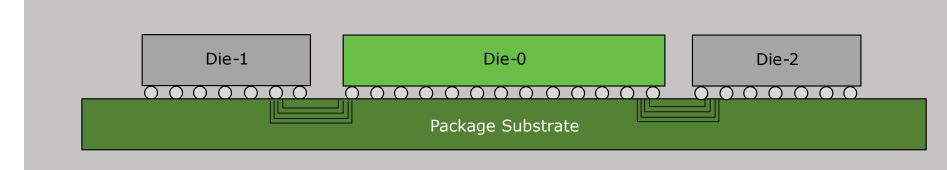
- Overcome reticle limits <u>SoC is now at package level</u>
- Reduces time-to-solution (e.g., enables die reuse)
- Lowers portfolio cost (product & project)
 - Optimal process
 - Smaller dies => better yield
 - Reduces IP porting costs
 - Lowers product SKU cost
- Bespoke solution
 - Mix-and-match with a standard interface
- Scales innovation (Mfg. process locked IPs)

UCIe 1.0 and 1.1 Specification: 2D/ 2.5D interconnect

- Layered Approach industry-leading KPIs
- Physical Layer: Die-to-Die I/O
- Die to Die Adapter:
 - Reliable delivery, Multi-protocol support
- Protocol:
 - CXL®/PCIe® for volume attach, plug-n-play
 - SoC construction issues are addressed w/ CXL/PCIe
 - Usages: I/O attach, Memory, Accelerator
 - Streaming for other protocols
 - Scale-up (e.g., CPU/ GP-GPU/Switch from smaller dies)
- Well defined specification
 - Configuration register for discovery and run-time
 - Form-factor and Management
 - Compliance for interoperability
 - Plug-and-play IPs with RDI/ FDI interface



UCIe 1.0/1.1: Supports Standard and Advanced Packages

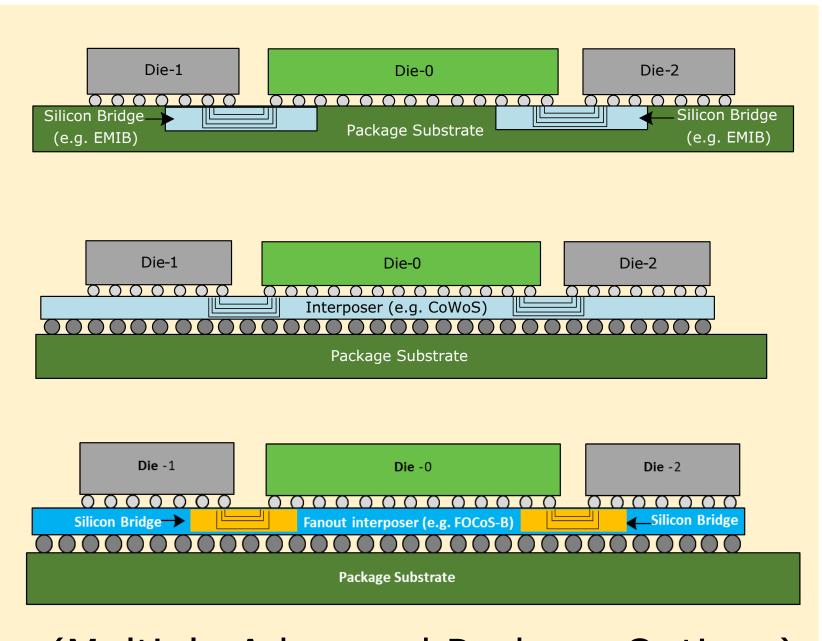


(Standard Package)

Standard Package: 2D – cost effective, longer distance

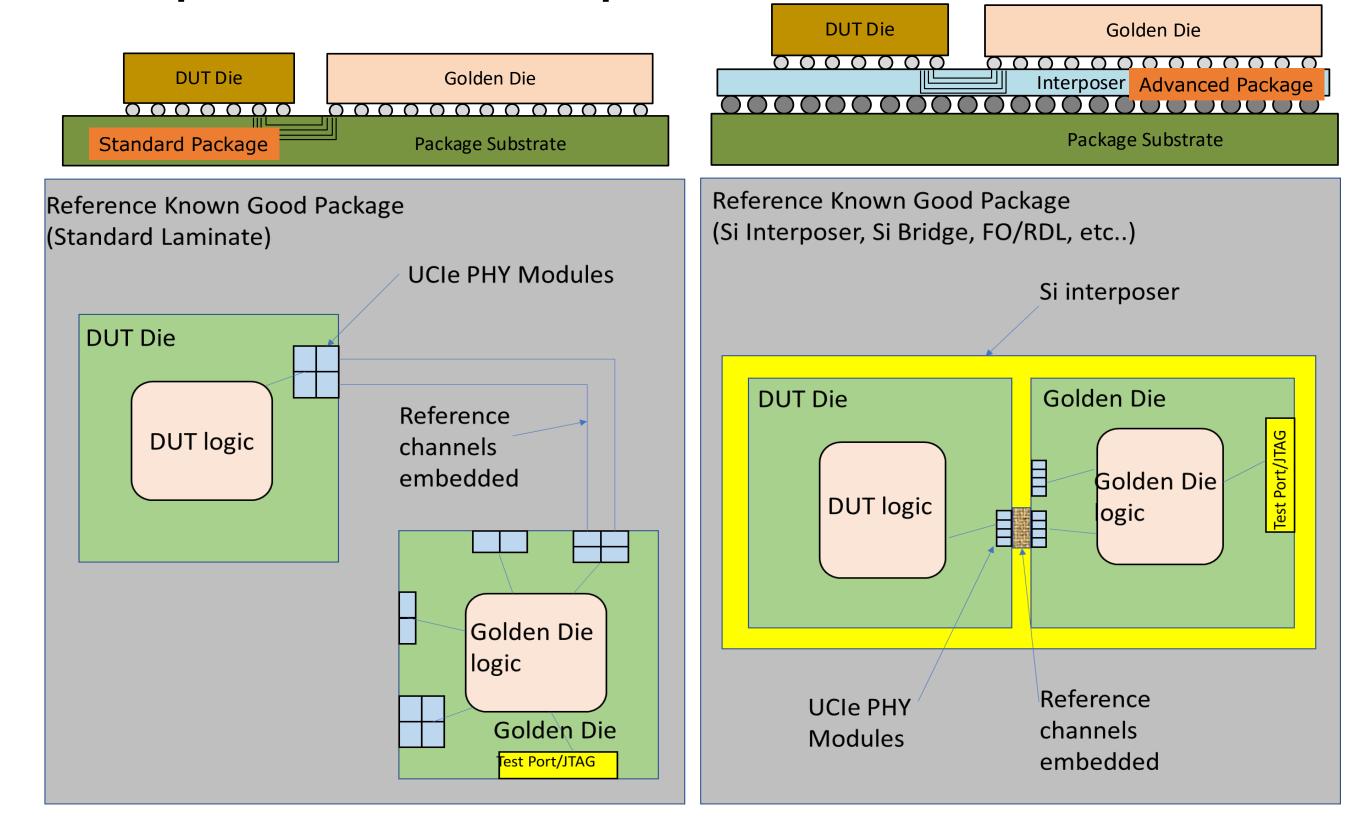
Advanced Package: 2.5D – power-efficient, high bandwidth density

Dies can be manufactured anywhere and assembled anywhere – can mix 2D and 2.5D in same package: Flexibility for SoC designer



(Multiple Advanced Package Options)

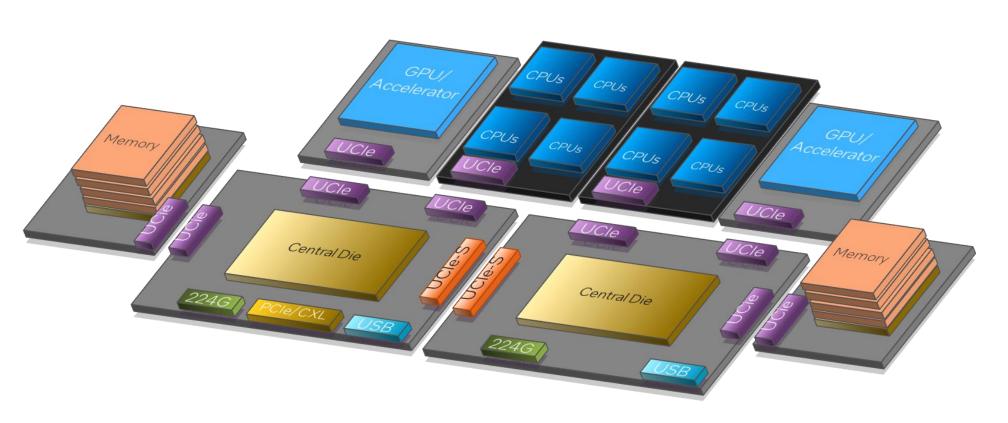
UCIe Compliance: Setup



Ingredients: Reference known good package with Reference Channels, Golden Die, DUT

UCIe Usage Model: System in Package

- SoC as a Package level construct
 - Standard and/ or Advanced package
 - Homogeneous/ heterogeneous chiplets
 - Chiplets from multiple suppliers
- Across all segments:
 - Hand-held, Client, Server, Workstation, Automotive, Comms, HPC, etc.
 - Similar to PCIe/ CXL at board level

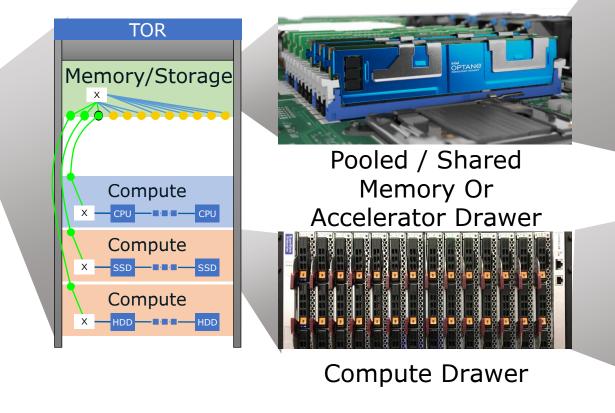


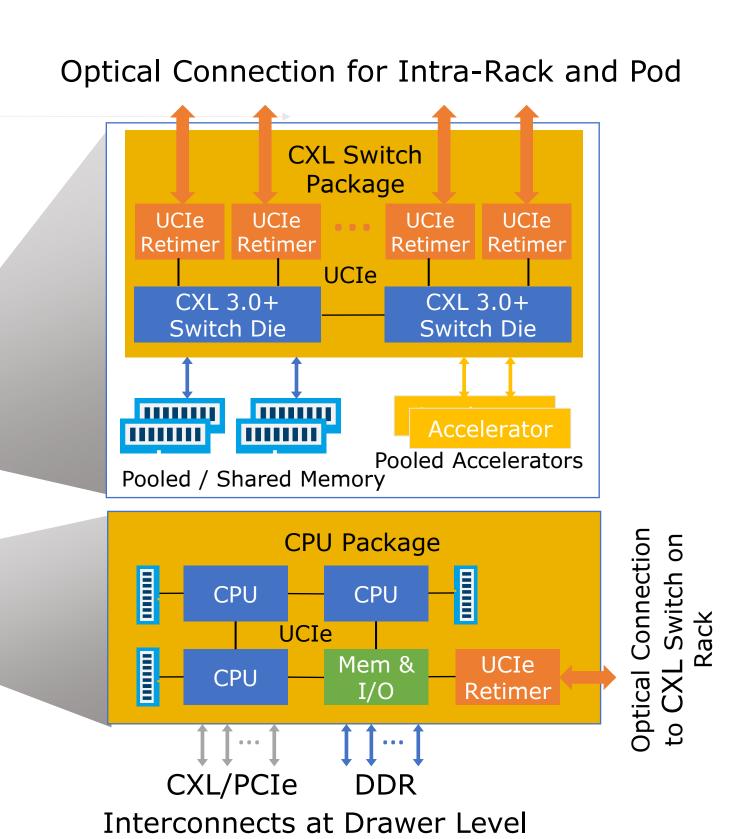
Off-Package Connectivity with UCIe Retimers: Composability at Rack/ Pod Level

Pod of Racks
Physical connectivity
using UCIe-Retimer-based
co-packaged optics
carrying CXL protocol

UCIe-based co-packaged Optics for Rack/Pod Level Connectivity running CXL protocol







Agenda

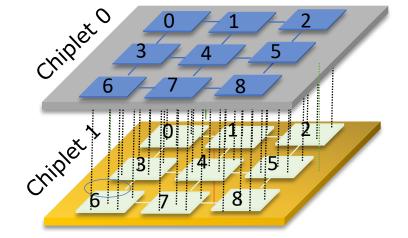
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UCIe-3D: Opportunities and Challenges

- 3D deployed in commercial offerings (Memory, CPU)
 - Hybrid bonding (HB) looks promising
 - Standardize for constrained interop (e.g., bump pitch match)
- High bandwidth density
 - 3D => areal connectivity (vs shore-line in 2D/ 2.x D)
 - Bump pitches aggressively shrinking
 - Number of wires increases inversely as the square of bump pitch
 - Must ensure we continue to be <u>bump-limited</u>
- Low power
 - Reduced interconnect distance (~0) between dies, electrical parsitics
 - Simple circuits and lower frequency are essential
- Better power, bandwidth, and latency than UCIe 2.5D

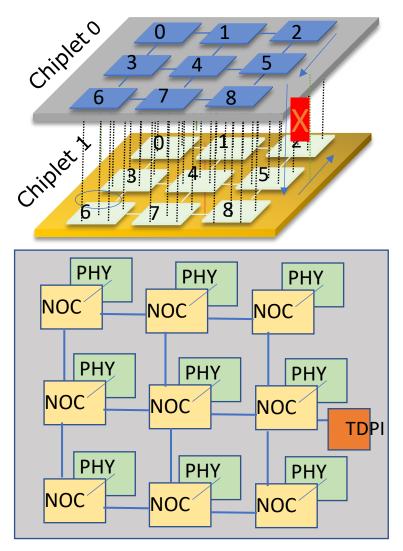
3D can deliver power-efficient performance comparable/ better than large monolithic die

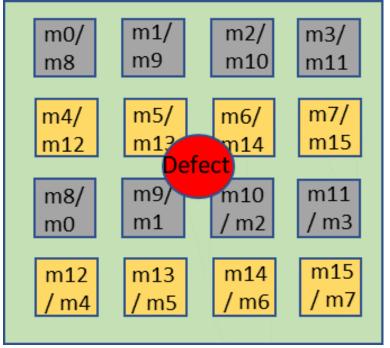




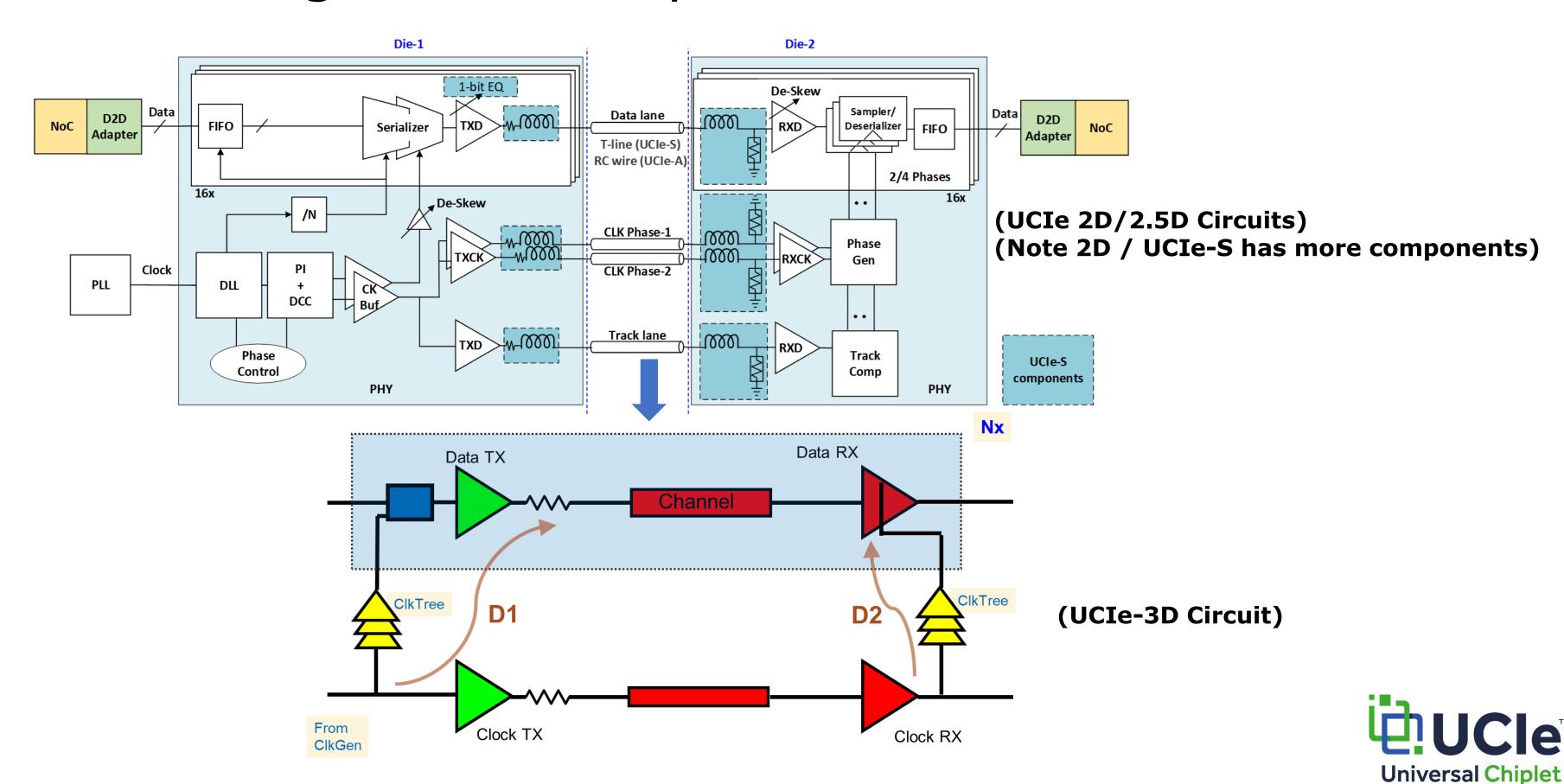
UCIe-3D Approach: Towards Compelling KPIs

- PHY: unidirectional, forwarded clock, Hard IP
 - No ESD, inverter-based design
 - Lower frequency for lower power/area
 - No (de)serialization .. No deskew
- No D2D Adapter: NOC directly connected to PHY
 - BER 1E-27 -> 1E-30 no CRC/ Replay
 - Repair: cluster level a defect may impact multiple ubumps
- Centralized (chiplet) level function
 - Test, Debug, Pattern gen/ check Infrastructure (TDPI)
 - Amortizes overhead since there will be multiple Links



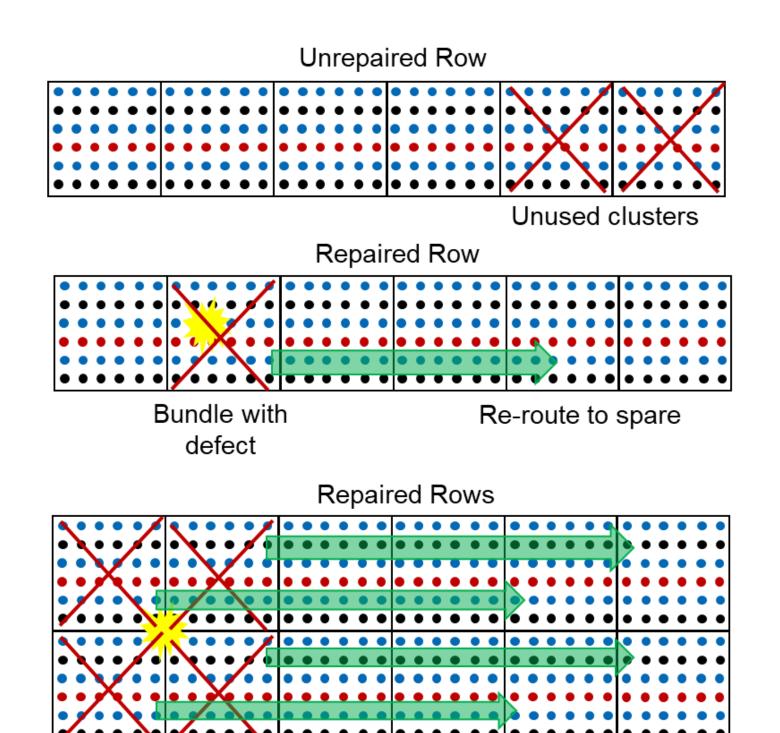


UCIe-3D: Significant Simplification over UCIe 2.5D/2D



Repair: Baseline Approach

- Reserve modules in SoC for repair, reroute to the backup module when there is a failure.
 - To address cluster failure mode. Defects are larger than bumps. For example, one defect can take out 5x5 bump area.
- UCIe-3D: Each Module has one TX bundle (x64 TX + Clock) and one RX bundle (x64 RX + Clock). Bundle layout is roughly a square, ~ 100um x 100um for 9um bump pitch.
- For densely packed UCIe Module array, reserve 2 full Modules (4 bundles) to repair one failure cluster.
 - Assume alternating TX, RX bundle in at least one direction.



Bundles with defect

Re-route to spare

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SiP Challenges: Testability, Debug, Telemetry, and Manageability: Design for Testability/ Debug/

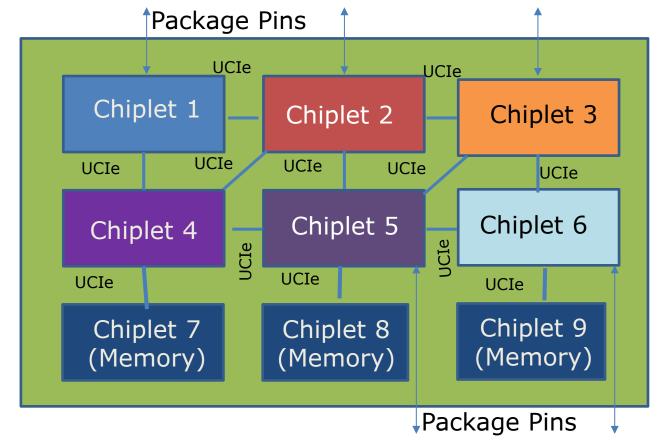
Manageability (DFx)

- UCIe 1.0/1.1 already has several mechanisms in place for DFx at the interconnect level
 - E.g., lane margin, loopback, compliance, fault reporting, sideband, etc
- Need to look at the entire chiplet/ package in a holistic manner to ensure a thriving chiplet-based plug-and-play ecosystem
- Test: Die / Sort, Package / Bond
 - Micro-bumps can not be probed => Use other bumps (e.g. JTAG, UCIe-S)
- Debug in lab and field (e.g., can not use a scope/ logic analyzer)
- Manageability w/ security (e.g., repair, firmware upgrades)
- Some chiplets may not have access to package pins
 - Use UCIe to access remote chiplets from chiplets with package pins (dedicated UCIe-S/ muxed)
- Wide range of bandwidth demands

Common infrastructure for entire lifecycle.

Leverage existing package pins and standards

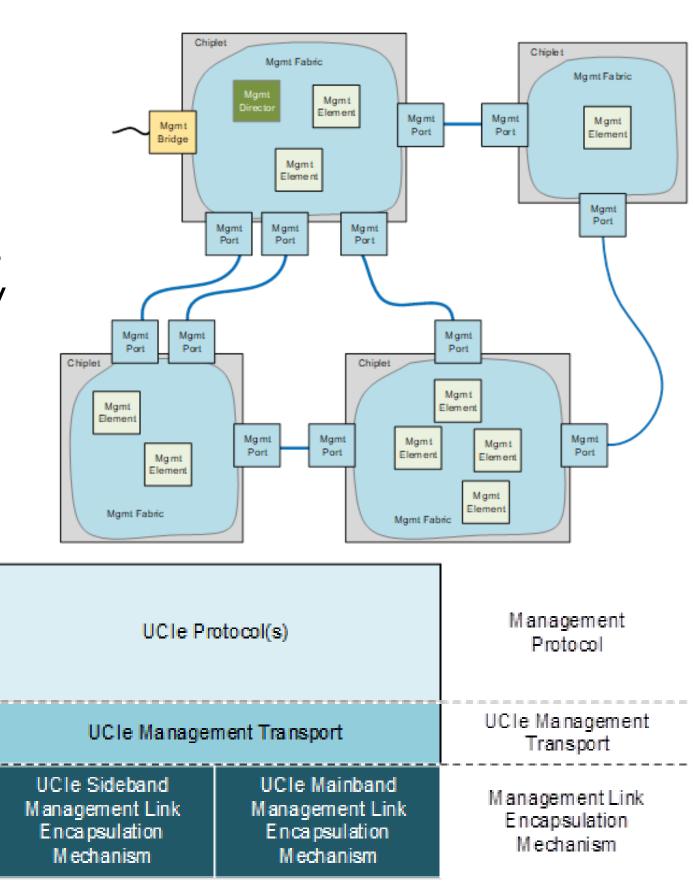
Added SB-only as well as x8 UCIe-S dedicated port for DFx



Interface	Bandwidth
UCIe-S x16	512 Gb/s/dir main @ 32G (800 Mb/s/dir sideband)
PCIe6.0 x16	1024 Gb/s/dir
USB 4.0	80 Gb/s/dir
JTAG (IEEE 1149.1)	5-100 Mb/s/dir
IEEE 1838	>100 Mb/s/dir with FPP
I2C/SMBus	400 Kb/s
I3C	33 Mb/s/dir

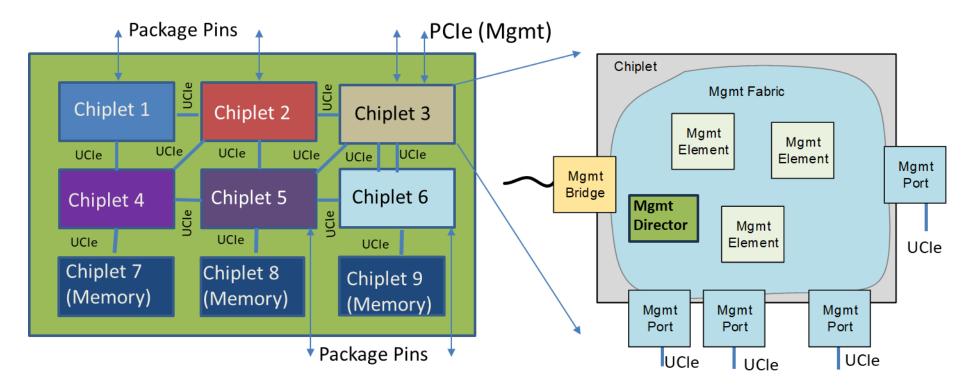
UCIe 2.0 Manageability Baseline Architecture

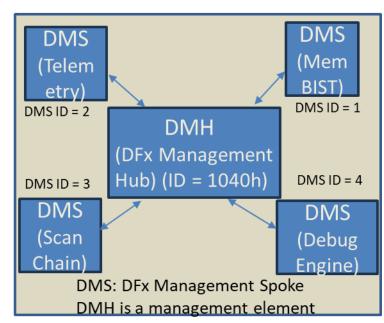
- Mechanisms supported: Discovery of chiplets and their configuration, initialization of chiplets and parameters (e.g., EEPROM replacement), firmware download, power/ thermal management, error reporting, telemetry, retrieval of crash dump log, test and debug, various aspects of chiplet security, etc.
- Protocol-agnostic builds on top of existing industry standards
- Management domain: chiplets that support UCIe manageability are interconnected through management ports, with a bridge to an external package pin (e.g., SMBus, PCIe)
 - Chiplets that don't support UCIe management are outside the domain
 - Management director: discovery, configuration, coordination of overall management within SiP, root of trust for manageability
- UCIe Management Transport end-to-end media-independent protocol for management communication on the management network (management entities within/ across chiplet(s))
- UCIe Management Transport Packet for communication
 - Sideband and Mainband
 - Up to 8 VCs, each with (un)ordered semantics
 - Credit based negotiated during link training



UCIe DFx Architecture (UDA): Common Infrastructure

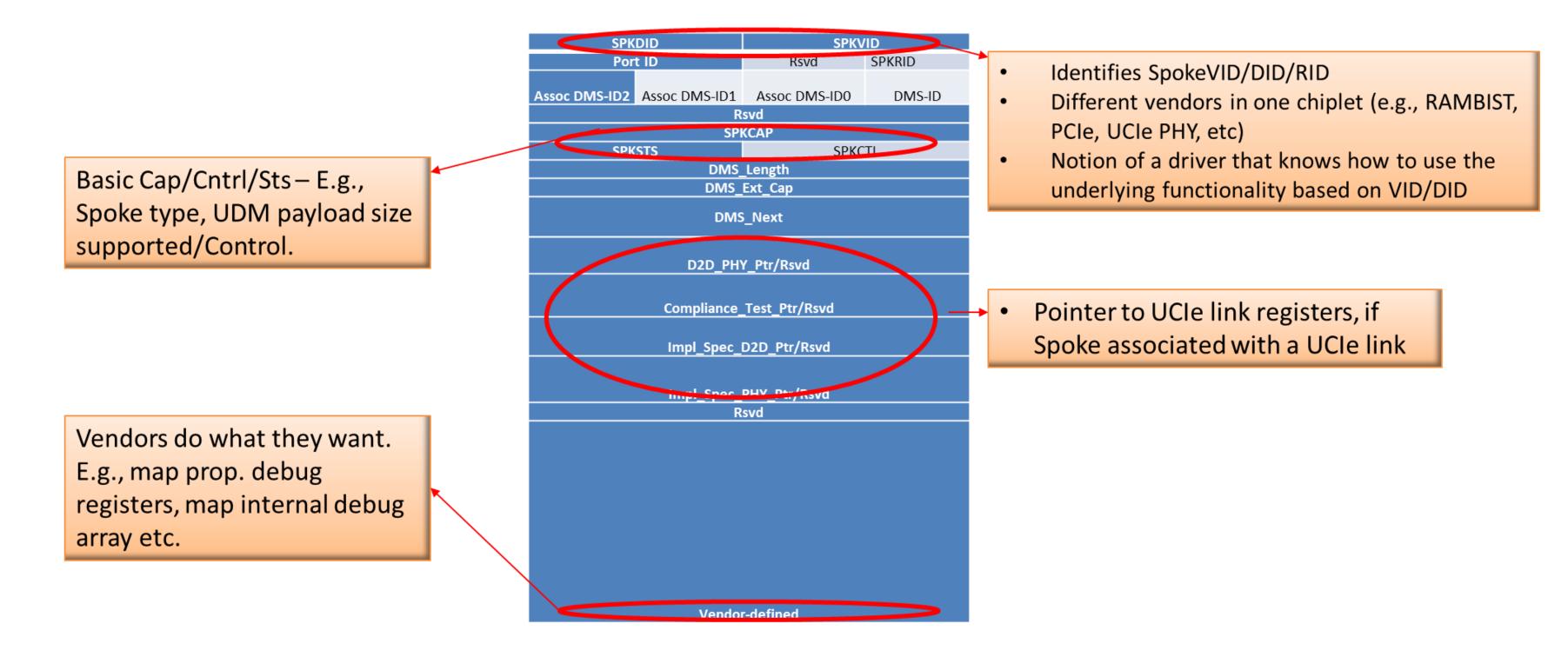
- UDA comprehends test, telemetry, debug covered through the management fabric
- Hub and Spoke(s) inside each chiplet
- DFx Management Hub (DMH) is a management element
 - Gateway to access test, debug, telemetry capability inside each chiplet
 - Routes the management transport packets to Spokes (DFx Mgmt Spoke: DMS)
 - Routes to other chiplet (DMH)
- DMS: test, debug, telemetry functions
 - E.g., Scan controller, Mem BIST, SoC Fabric debug, trace protocol engine, etc.
- Architected configuration registers on top of existing registers basically a UCIe wrapper on top of existing registers
- UCIe issued Vendor ID, Device ID, RID for spoke







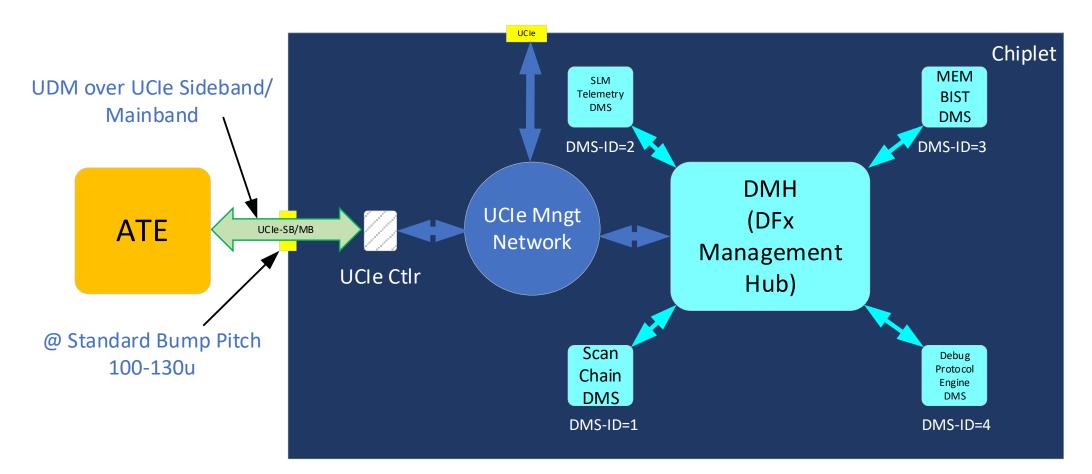
Standardized Configuration for Test, Debug, Manageability



UDA: Simple, minimal standard header for DMS; rest is vendor-defined



Example Usages of UDA

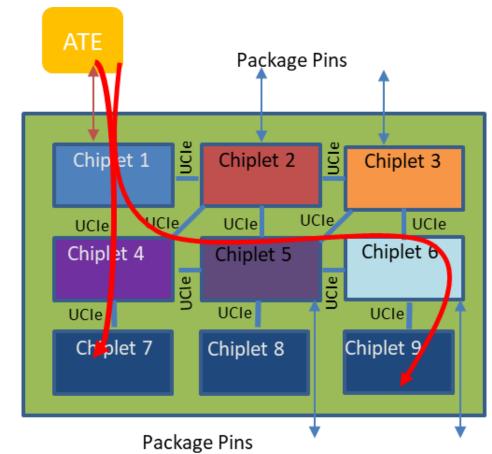


(a: ATE testing during sort using UCIe-S pins: sideband and/or mainband)

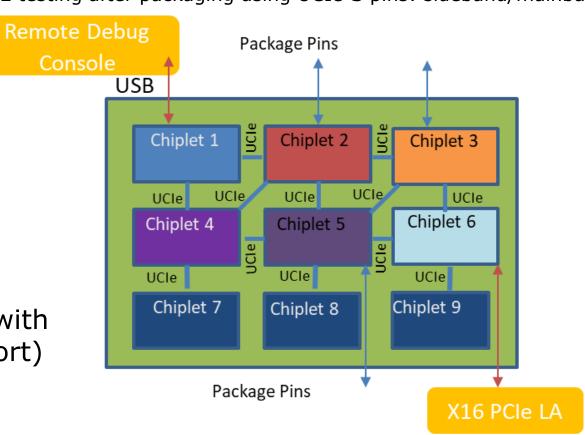
Package pins used for Test & Debug

Package pins used for functional purposes

(c: Routing multiple sets of debug signals from Chiplets through UCIe to a PCIe Logic Analyzer with The remote debug console (control) on a USB port)



(b: ATE testing after packaging using UCIe-S pins: sideband/mainband)





Key Metrics: Expanding Industry Leading KPIs to UCIe-3D

Characteristics / KPIs	UCIe-S (2D)	UCIe-A (2.5D)	UCIe 3D	Comments for UCIe 3D		
Characteristics						
Data Rate (GT/s)	4, 8, 12, 16, 24, 32		Up to 4	= SoC Logic frequency – power efficiency is critical		
Width (each cluster)	16	64	80	Options or reduced width to 70, 60		
Bump Pitch (µm)	100 - 130	25 – 55	<pre>< 10 (optimized)</pre>	Must scale so that UCIe-3D fits within the bump area, must support hybrid bonding		
Channel Reach (mm)	<u><</u> 25	<u><</u> 2	3D vertical	FtF bonding initially; FtB, BtB, multi-stack possible		
Target for Key Metrics						
BW Shoreline (GB/s/mm)	28 – 224	165 – 1317	N/A (vertical)			
BW Density (GB/s/mm ²)	22 – 125	188 – 1350	4,000 - 300,000	4TB/s/mm ² @ 9μm, ~12TB/s/mm ² @ 5μm, ~35TB/s/mm ² @ 3μm, ~300TB/s/mm ² @ 1 μm		
Power Efficiency Target (pJ/b)	0.5	0.25	<0.05 at 9µm -> 0.01 at 1 µm	Conservatively estimated at 9µm pitch <0.02 for 3µm pitch		
Low-Power Entry/Exit	0.5nS <u>< 16</u> G, 0.5-1nS <u>> 24</u> G		0nS	No preamble or post-amble		
Reliability (FIT)	0 < FIT (Failure in Time) << 1		0 < FIT << 1	BER < 1E-27		
ESD	30V CDM		5V CDM → <u><</u> 3V	5V CDM at introduction, no ESD for W2W hybrid bonding possible		

UCIe-3D will deliver compelling power-efficient performance



Future Directions and Conclusions

- UCIe Consortium continues to evolve UCIe technology in a backward-compatible manner comprehending new usage models, additional cost optimization, and towards a robust compliance mechanism.
- UCIe is an open industry standard that establishes an open chiplet ecosystem and ubiquitous interconnect at the package level.
 - Tremendous support across the industry with several companies announcing IP/VIP availability
 - Evolving as the interconnect of SoCs just as PCIe and CXL at the board level
 - UCIe 2.0 Specification is available to the public https://www.uciexpress.org/specification
- UCIe Consortium welcomes interested companies and institutions to join the organization at the Contributor or Adopter level.
- 6 Technical Working Groups (Electrical, Protocol, Form Factor/Compliance, Manageability/Security, Systems and Software, Automotive) alongside the Marketing Working Group are driving the technology toward the future.
 - Incredible innovation happening in the Consortium!
- Get involved! Learn more by visiting <u>www.UCIexpress.org</u>



Questions?



Thank You

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